Application/Control No. Applicant(s)/Patent Under Reexamination 10/766,910 YAMANE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1725 Len Tran **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-4,016,926 04-1977 Yamada et al. 164/504 Α US-В

FOREIGN PATENT DOCUMENTS

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